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NDB7060L

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FAIRCHILD SEMICONDUCTOR TM

June 1996

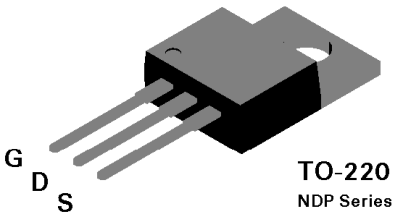
NDP7060L / NDB7060L
N-Channel Logic Level Enhancement Mode Field Effect Transistor

General Description

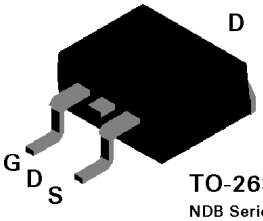
These logic level N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as automotive, DC/DC converters, PWM motor controls, and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

Features

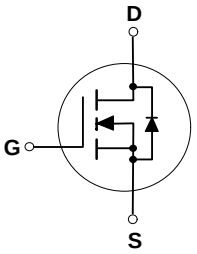
- 75A, 60V. $R_{DS(ON)}$ = 0.015Ω @ V_{GS} = 5V
- Low drive requirements allowing operation directly from logic drivers. $V_{GS(TH)}$ < 2.0V.
- Critical DC electrical parameters specified at elevated temperature.
- Rugged internal source-drain diode can eliminate the need for an external Zener diode transient suppressor.
- 175°C maximum junction temperature rating.
- High density cell design for extremely low $R_{DS(ON)}$.
- TO-220 and TO-263 (D^2PAK) package for both through hole and surface mount applications.



TO-220
NDP Series



TO-263AB
NDB Series



Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	NDP7060L	NDB7060L	Units
V_{DSS}	Drain-Source Voltage	60		V
V_{DGR}	Drain-Gate Voltage (R_{GS} ≤ 1 MΩ)	60		V
V_{GSS}	Gate-Source Voltage - Continuous	± 20		V
	- Nonrepetitive (t_p < 50 µs)	± 40		
I_D	Drain Current - Continuous	75		A
	- Pulsed	225		
P_D	Total Power Dissipation @ T_C = 25°C	150		W
	Derate above 25°C	1		W/°C
T_J,T_{STG}	Operating and Storage Temperature Range	-65 to 175		°C

Electrical Characteristics (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
DRAIN-SOURCE AVALANCHE RATINGS (Note 1)							
W_{DSS}	Single Pulse Drain-Source Avalanche Energy	V_{DD} = 25 V, I_D = 75 A				550	mJ
I_{AR}	Maximum Drain-Source Avalanche Current					75	A
OFF CHARACTERISTICS							
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 µA		60			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 60 V, V_{GS} = 0 V				250	µA
			T_J = 125°C			1	mA
I_{GSSF}	Gate - Body Leakage, Forward	V_{GS} = 20 V, V_{DS} = 0 V				100	nA
I_{GSSR}	Gate - Body Leakage, Reverse	V_{GS} = -20 V, V_{DS} = 0 V				-100	nA
ON CHARACTERISTICS (Note 1)							
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 µA		1	1.3	2	V
			T_J = 125°C	0.65	0.8	1.5	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} = 5 V, I_D = 37.5 A			0.01	0.015	Ω
			T_J = 125°C		0.016	0.024	
$I_{D(on)}$	On-State Drain Current	V_{GS} = 5 V, V_{DS} = 10 V		75			A
g_{FS}	Forward Transconductance	V_{DS} = 10 V, I_D = 37.5 A		15	67		S
DYNAMIC CHARACTERISTICS							
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz			4200	4000	pF
C_{oss}	Output Capacitance				1100	1600	pF
C_{rss}	Reverse Transfer Capacitance				310	800	pF
SWITCHING CHARACTERISTICS (Note 1)							
$t_{D(on)}$	Turn - On Delay Time	V_{DD} = 30 V, I_D = 75 A, V_{GS} = 5 V, R_{GEN} = 10Ω R_{GS} = 10 Ω			23	40	nS
t_r	Turn - On Rise Time				460	600	nS
$t_{D(off)}$	Turn - Off Delay Time				100	150	nS
t_f	Turn - Off Fall Time				270	400	nS
Q_g	Total Gate Charge	V_{DS} = 48 V, I_D = 75 A, V_{GS} = 5 V			86	115	nC
Q_{gs}	Gate-Source Charge				13		nC
Q_{gd}	Gate-Drain Charge				62		nC

Electrical Characteristics (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS						
I_S	Maximum Continuos Drain-Source Diode Forward Current				75	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current				225	A
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 37.5 A (Note 1)		0.92	1.3	V
		T_J = 125°C		0.85	1.2	
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_F = 60A, dI_F/dt = 100 A/µs		108	150	ns
I_{rr}	Reverse Recovery Current			4.6	10	A
THERMAL CHARACTERISTICS						
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case				1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient				62.5	°C/W

Note:
1. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2.0%.

Typical Electrical Characteristics

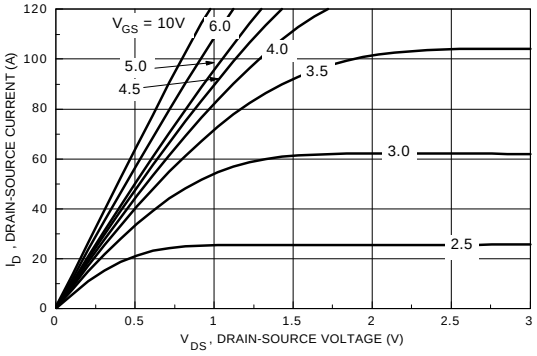


Figure 1. On-Region Characteristics.

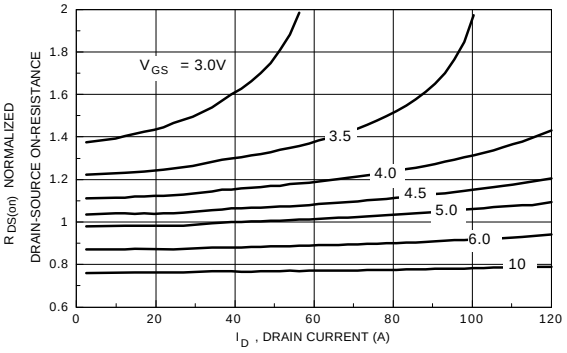


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current.

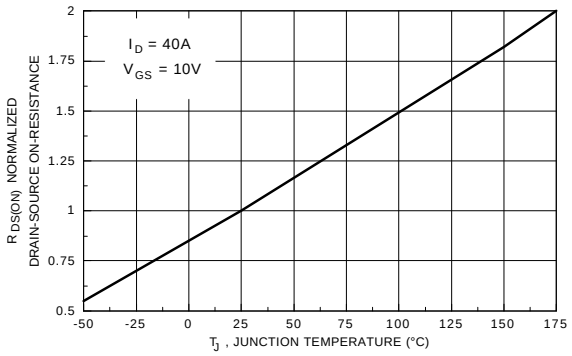


Figure 3. On-Resistance Variation with Temperature.

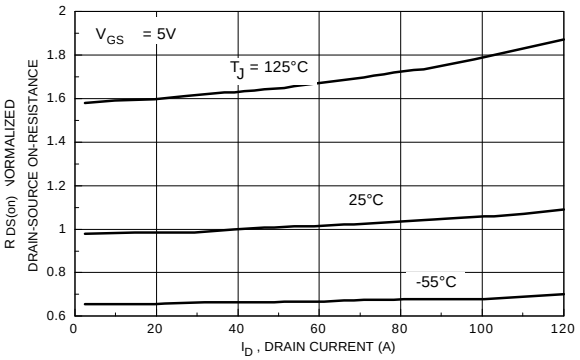


Figure 4. On-Resistance Variation with Drain Current and Temperature.

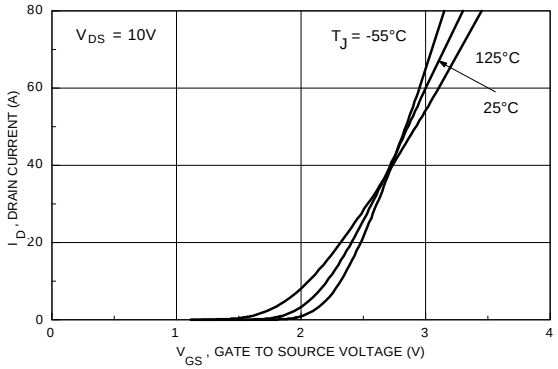


Figure 5. Transfer Characteristics.

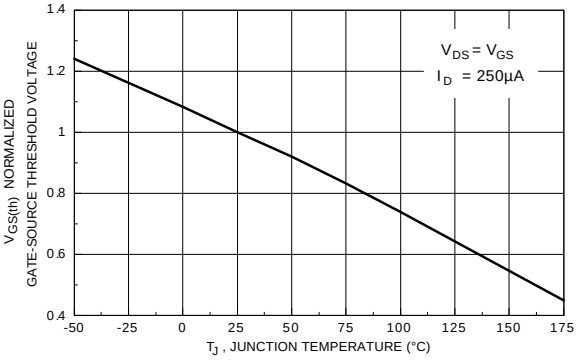


Figure 6. Gate Threshold Variation with Temperature.

Typical Electrical Characteristics (continued)

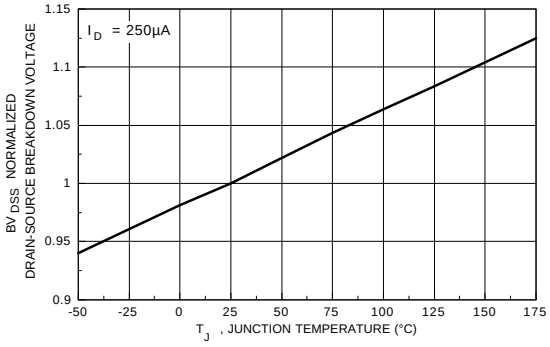


Figure 7. Breakdown Voltage Variation with Temperature.

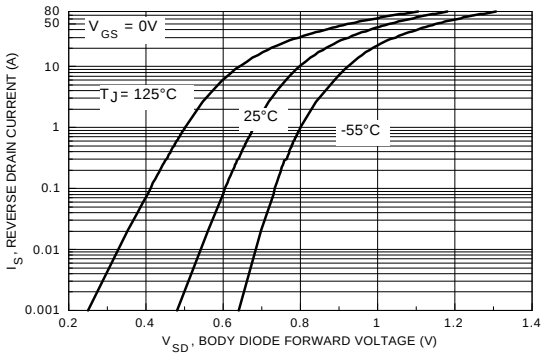


Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.

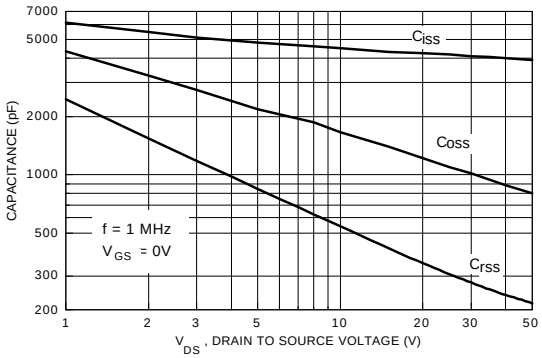


Figure 9. Capacitance Characteristics.

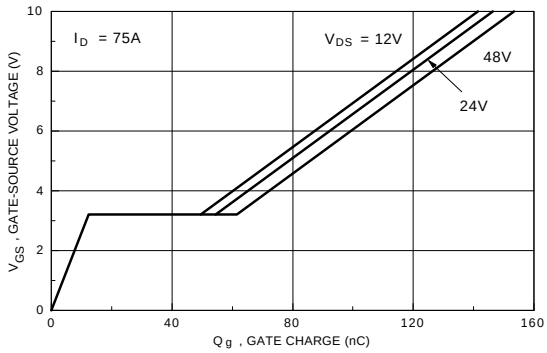


Figure 10. Gate Charge Characteristics.

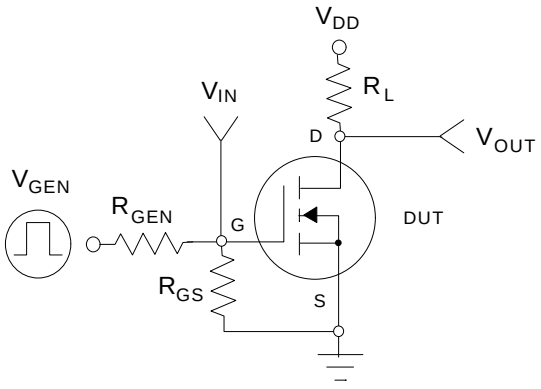


Figure 11. Switching Test Circuit.

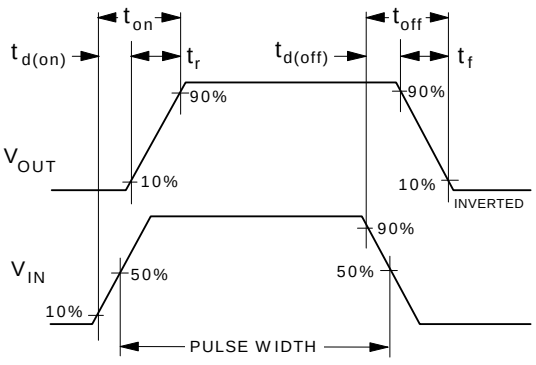


Figure 12. Switching Waveforms.

Typical Electrical Characteristics (continued)

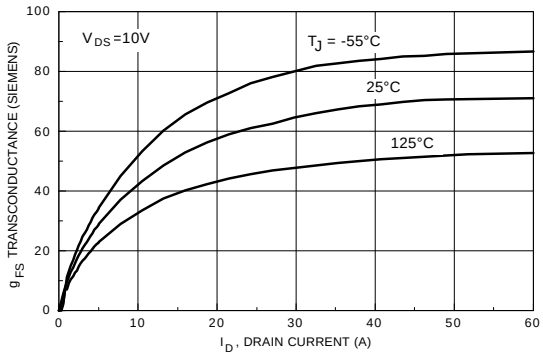


Figure 13. Transconductance Variation with Drain Current and Temperature.

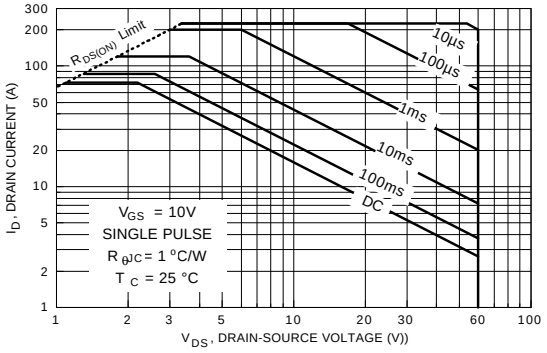


Figure 14. Maximum Safe Operating Area.

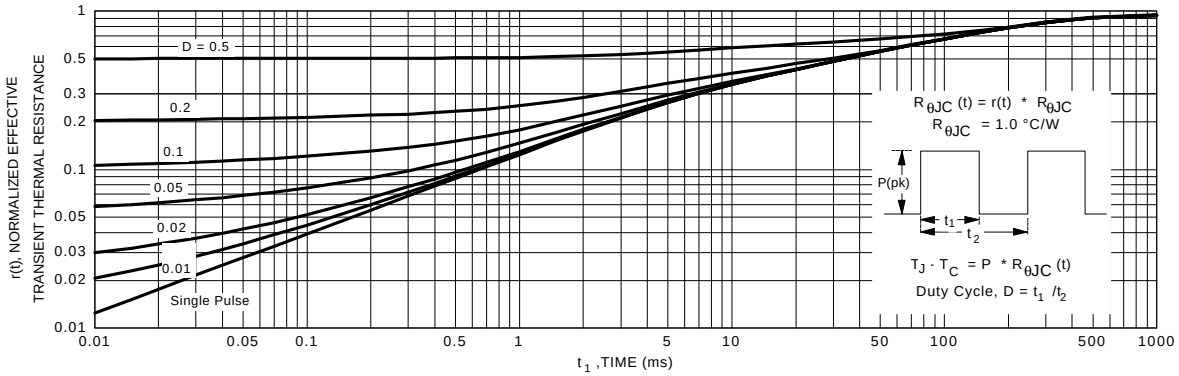


Figure 15. Transient Thermal Response Curve.